

<b>Notice of References Cited</b>	Application/Control No. 10/616,508	Applicant(s)/Patent Under Reexamination SHIN, HYEON SANG	
	Examiner James M. Mitchell	Art Unit 2813	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2004/0152260	08-2004	Rabkin et al.	438/257
	B	US-6,791,142	09-2004	Tseng, Horng-Huei	257/316
	C	US-6,654,793	11-2003	Wollrath et al.	709/217
	D	US-6,107,143	08-2000	Park et al.	438/296
	E	US-2002/0094641	07-2002	Shin et al.	438/257
	F	US-6,830,969	12-2004	Woo, Won Sic	438/218
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.